

Neutron Powder Diffraction Profile Refinement Studies on CaMoO_4 . A Comparison with Single-Crystal Data

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The last decade has shown a strong development in structure analysis based on neutron powder diffraction data, and reviews on this subject by Cheetham and Taylor,¹ and by Taylor² have appeared in recent years. The combination of a high neutron flux at a fixed wavelength, and a diffractometer with an array of detectors like the instrument D1A at ILL^{3,5} or the diffractometer at LLB* used in this investigation makes it possible to record a complete powder diffraction pattern in less than a day. An essential breakthrough in the application of neutron powder diffraction data in investigations of the structure of solids came with the profile refinement method developed by Rietveld.⁴

Taylor² has recently reviewed how well powder diffraction analysis using the Rietveld profile refinement method⁴ has performed in comparison with single crystal investigations. The aim was to examine how well the positions of oxygen atoms in metal-oxygen containing inorganic compounds can be determined.

A neutron diffraction profile refinement can also supplement a neutron single-crystal investigation if the powder pattern can be measured to considerably greater values of $\sin\theta/\lambda$ than those used in the single-crystal measurement. The profile refinement of the structure of CaMoO_4 described below illustrates this.

CaMoO_4 has the scheelite (CaWO_4) structure, and one of the recent investigations of the structure was a neutron single-crystal measurement employing a total of 35 independent reflections by Gürmen *et al.*⁵ (see Table 1).

The sample of CaMoO_4 used in this investigation was prepared from a stoichiometric mixture of CaO, made from CaCO_3 by ignition in a crucible furnace at 900° for 24 h, and MoO_3 (Merck *p.a.*). The mixture was pressed isostatically to a cylindrical rod that was kept in a MgO crucible in a crucible furnace at 1000°C for 24 h. The rod of CaMoO_4 was crushed in a boron carbide mortar, and a Guinier photograph showed that the sample was pure CaMoO_4 .

The neutron powder diffraction pattern was recorded on the diffractometer at channel 3T2 at the ORPHEE reaction at the *Laboratoire Léon Brillouin*, Saclay. The neutron wavelength was 1.226 Å, and the 2θ range was 8–110°. The scattering lengths used in the profile refinements were: Ca 0.3449, Mo 0.661 and O 0.577, all in 10^{-12} cm units.⁶ The profile refinement program⁷ yielded the coordinates listed in Table 1, with the parameters from Ref. 5 as starting values. From Table 1 it is observed that the precision obtained in this investigation is higher than that arrived at in Ref. 5. In the single-crystal investigation reflections were measured only to what in the present work corresponds to $\sin\theta/\lambda = 0.58$, and some reflections were systematically omitted. When reflections with $\sin\theta/\lambda > 0.58$ were omitted in the profile refinement, the precision was still better

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Table 1. Crystallographic data for CaMoO₄. Space group *I*4₁/*a* (No. 88), *Z* = 4.

This work					Ref. 5				
<i>a</i> = 5.2235(1) Å					<i>a</i> = 5.226 Å				
<i>c</i> = 11.4298(4) Å					<i>c</i> = 11.43 Å				
194 reflections, <i>R</i> = 7.14 %					35 reflections, <i>R</i> = 7.3 %				
Atom	Site	<i>x</i>	<i>y</i>	<i>z</i>	<i>B</i> (Å ²)	<i>x</i>	<i>y</i>	<i>z</i>	<i>B</i> (Å ²)
Ca	4(<i>b</i>)	0	0	1/2	0.819(67)	0	0	1/2	0.606(280)
Mo	4(<i>a</i>)	0	0	0	0.496(47)	0	0	0	0.364(205)
O	16(<i>f</i>)	0.2436(4)	0.1490(3)	0.0842(2)	0.778(27)	0.2428(10)	0.1465(10)	0.0826(3)	0.747(178)
Mo–O distance		1.775(2) Å			1.757(5) Å				
Mo–O distance		1.776(3) Å ^a							

^aReflections with $\sin\theta/\lambda > 0.58$ omitted.

than that obtained in Ref. 5. It has been reported⁸ that the standard deviations estimated for Rietveld refinements are too low. However, even if the value for the standard deviation arrived at for the Mo–O distance [1.775(2) Å] is doubled, the estimated standard deviation is still not greater than that reported in Ref. 5.

Fig. 1 shows the observed and calculated profiles for the diffraction pattern of CaMoO₄. The pattern has weak contributions from aluminium from the sample container, and the 2θ regions

with stronger aluminium reflections, viz. 30.15–30.65, 34.80–35.50, 60.25–61.00, 74.35–74.65 and 82.40–83.00, have been omitted. It is possible that the profile shape function is not a pure Gaussian function, as assumed in the program used. The reflection at the 2θ position 22.80° shows misfit on the two sides of the peak close to the background level. For this reason the profile refinement was repeated using the program EDINP,⁹ in which a Voigt profile function is applied. This is a convolution of a Gaussian and a

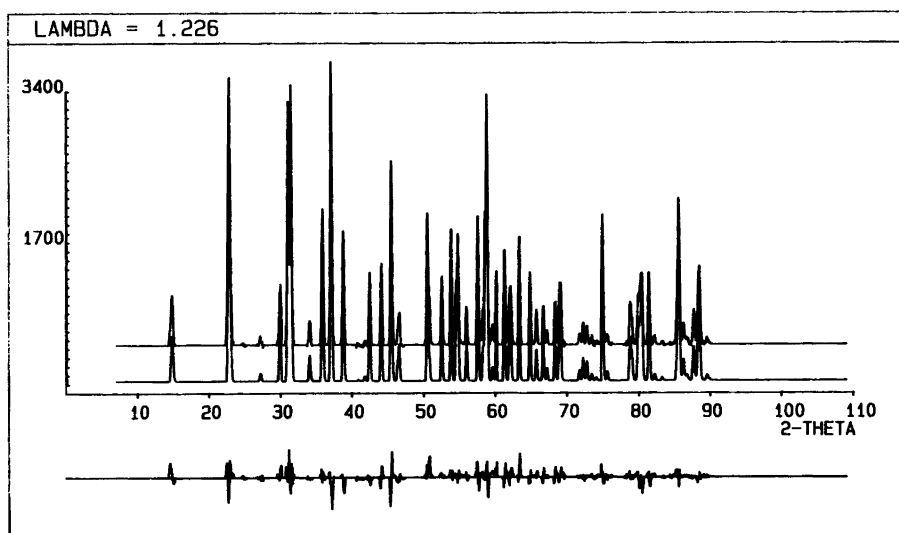


Fig. 1. Neutron powder diffraction diagram for CaMoO₄ obtained with 1.226 Å neutrons. Upper curve: observed intensity; lower: calculated intensity; below the abscissa: difference between observed and calculated intensities.

SHORT COMMUNICATION

Lorentzian function. This refinement gave no improvement in the precision of the structure.

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